CMOS Digital Integrated Circuits Silicon Monolithic

74HC174D

1. Functional Description

· Hex D-Type Flip-Flop with Clear

2. General

The 74HC174D is a high speed CMOS D-TYPE FLIP FLOP fabricated with silicon gate C2MOS technology.

It achieves the high speed operation similar to equivalent LSTTL while maintaining the CMOS low power dissipation.

Information signals applied to the D inputs are transferred to the Q outputs on the positive going edge of the clock pulse.

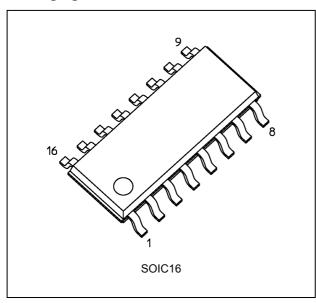
When the CLR input is held low, the Q outputs are in the low logic level independent of the other inputs.

All inputs are equipped with protection circuits against static discharge or transient excess voltage.

3. Features

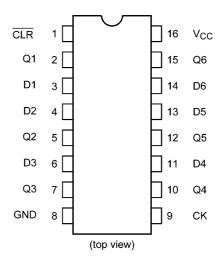
- (1) High speed: $f_{MAX} = 71 \text{ MHz}$ (typ.) at $V_{CC} = 5 \text{ V}$
- (2) Low power dissipation: $I_{CC} = 4.0 \mu A \text{ (max)}$ at $T_a = 25 \text{°C}$
- (3) Balanced propagation delays: $t_{PLH} \approx t_{PHL}$
- (4) Wide operating voltage range: $V_{CC(opr)} = 2.0 \text{ V}$ to 6.0 V

4. Packaging

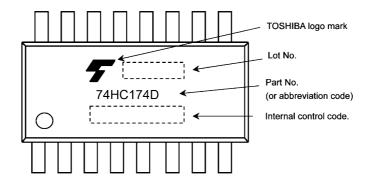




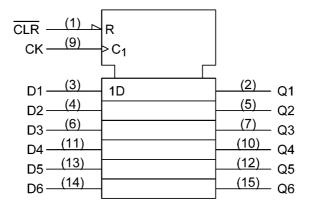
5. Pin Assignment



6. Marking



7. IEC Logic Symbol



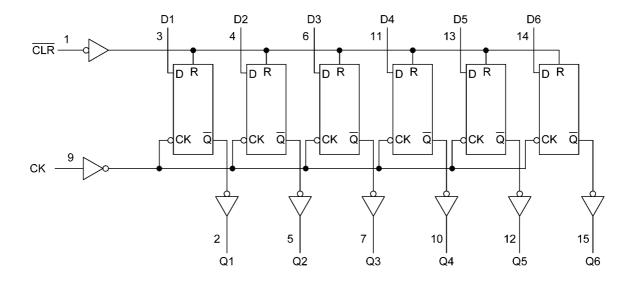


8. Truth Table

	Inputs		Output	F oti o
CLR	D	СК	Q	Function
L	Х	Х	L	Clear
Н	L		L	_
Н	Н	k-	Н	-
Н	Х		Qn	No Change

X: Don't care

9. System Diagram





10. Absolute Maximum Ratings (Note)

Characteristics	Symbol	Note	Rating	Unit
Supply voltage	V _{CC}		-0.5 to 7.0	V
Input voltage	V _{IN}		-0.5 to V _{CC} + 0.5	V
Output voltage	V _{OUT}		-0.5 to V _{CC} + 0.5	V
Input diode current	I _{IK}		±20	mA
Output diode current	l _{ok}		±20	mA
Output current	l _{out}		±25	mA
V _{CC} /ground current	I _{CC}		±50	mA
Power dissipation	P _D		500	mW
Storage temperature	T _{stg}		-65 to 150	°C

Note: Exceeding any of the absolute maximum ratings, even briefly, lead to deterioration in IC performance or even destruction.

Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings and the operating ranges.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

11. Operating Ranges (Note)

Characteristics	Symbol	Test Condition	Rating	Unit
Supply voltage	V _{CC}		2.0 to 6.0	V
Input voltage	V _{IN}		0 to V _{CC}	V
Output voltage	V _{OUT}		0 to V _{CC}	V
Operating temperature	T _{opr}		-40 to 85	°C
Input rise and fall times	t _r ,t _f	V _{CC} = 2.0 V	0 to 1000	ns
		V _{CC} = 4.5 V	0 to 500	
		V _{CC} = 6.0 V	0 to 400	

Note: The operating ranges must be maintained to ensure the normal operation of the device. Unused inputs must be tied to either V_{CC} or GND.



12. Electrical Characteristics

12.1. DC Characteristics (Unless otherwise specified, $T_a = 25$ °C)

Characteristics	Symbol	Test Condition	ı	V _{CC} (V)	Min	Тур.	Max	Unit
High-level input voltage	V _{IH}	_		2.0	1.50	_	_	V
				4.5	3.15	_	_	
				6.0	4.20	_	_	
Low-level input voltage	V _{IL}	_		2.0	_	_	0.50	V
				4.5	_	_	1.35	
				6.0	_		1.80	
High-level output voltage	V _{OH}	V _{IN} = V _{IH} or V _{IL}	I _{OH} = -20 μA	2.0	1.9	2.0	_	V
				4.5	4.4	4.5	_	
				6.0	5.9	6.0	_	
			I _{OH} = -4 mA	4.5	4.18	4.31	_	
			I_{OH} = -5.2 mA	6.0	5.68	5.80	_	
Low-level output voltage	V _{OL}	V _{IN} = V _{IH} or V _{IL}	I _{OL} = 20 μA	2.0	_	0.0	0.1	V
				4.5	_	0.0	0.1	
				6.0	_	0.0	0.1	
			I _{OL} = 4 mA	4.5	_	0.17	0.26	
			I _{OL} = 5.2 mA	6.0		0.18	0.26	
Input leakage current	I _{IN}	V _{IN} = V _{CC} or GND		6.0	_		±0.1	μА
Quiescent supply current	I _{CC}	$V_{IN} = V_{CC}$ or GND		6.0	_		4.0	μΑ

12.2. DC Characteristics (Unless otherwise specified, T_a = -40 to 85 °C)

Characteristics	Symbol	Test Condition	١	V _{CC} (V)	Min	Max	Unit
High-level input voltage	V _{IH}	_		2.0	1.50	_	V
				4.5	3.15	_	
				6.0	4.20	_	
Low-level input voltage	V _{IL}	_		2.0	_	0.50	V
				4.5	_	1.35	
				6.0	_	1.80	
High-level output voltage	V _{OH}	V _{IN} = V _{IH} or V _{IL}	I _{OH} = -20 μA	2.0	1.9	_	V
				4.5	4.4	_	
				6.0	5.9	_	
			I _{OH} = -4 mA	4.5	4.13	_	
			$I_{OH} = -5.2 \text{ mA}$	6.0	5.63	_	
Low-level output voltage	V _{OL}	V _{IN} = V _{IH} or V _{IL}	I _{OL} = 20 μA	2.0		0.1	V
				4.5	_	0.1	
				6.0	_	0.1	
			I _{OL} = 4 mA	4.5	_	0.33	
			I _{OL} = 5.2 mA	6.0	_	0.33	
Input leakage current	I _{IN}	$V_{IN} = V_{CC}$ or GND		6.0		±1.0	μА
Quiescent supply current	I _{CC}	$V_{IN} = V_{CC}$ or GND		6.0	_	40.0	μА



12.3. Timing Requirements (Unless otherwise specified, $T_a = 25^{\circ}C$, Input: $t_f = t_f = 6$ ns)

Characteristics	Symbol	Test Condition	V _{CC} (V)	Limit	Unit
Minimum pulse width	$t_{w(L)}, t_{w(H)}$	_	2.0	75	ns
(CK)			4.5	15	
			6.0	13	
Minimum pulse width	t _{w(L)}	_	2.0	75	ns
(CLR)			4.5	15	
			6.0	13	
Minimum setup time	t _S	_	2.0	75	ns
			4.5	15	
			6.0	13	
Minimum hold time	t _h	_	2.0	0	ns
			4.5	0	
			6.0	0	
Minimum removal time	t _{rem}	_	2.0	25	ns
(CLR)			4.5	5	
			6.0	4	
Clock frequency	f	_	2.0	6	MHz
			4.5	33	
			6.0	38	

12.4. Timing Requirements (Unless otherwise specified, T_a = -40 to 85°C, Input: t_r = t_f = 6 ns)

Characteristics	Symbol	Test Condition	V _{CC} (V)	Limit	Unit
Minimum pulse width	$t_{w(L)},t_{w(H)}$	_	2.0	95	ns
(CK)			4.5	19	
			6.0	16	
Minimum pulse width	t _{w(L)}	_	2.0	95	ns
(CLR)			4.5	19	
			6.0	16	
Minimum setup time	t _S	_	2.0	95	ns
			4.5	19	
			6.0	16	
Minimum hold time	t _h	_	2.0	0	ns
			4.5	0	
			6.0	0	
Minimum removal time	t _{rem}	_	2.0	30	ns
(CLR)			4.5	6	
			6.0	5	
Clock frequency	f	_	2.0	4	MHz
			4.5	26	
			6.0	30	



12.5. AC Characteristics (Unless otherwise specified, C_L = 15 pF, V_{CC} = 5 V, T_a = 25 °C, Input: t_r = t_f = 6 ns)

Characteristics	Symbol	Note	Test Condition	Min	Тур.	Max	Unit
Output transition time	t_{TLH}, t_{THL}		_	_	4	8	ns
Propagation delay time (CK-Q)	t _{PLH} ,t _{PHL}		_	_	14	26	ns
Propagation delay time (CLR-Q)	t _{PHL}		_	_	15	26	ns
Maximum clock frequency	f _{MAX}		_	39	71		MHz

12.6. AC Characteristics (Unless otherwise specified, C_L = 50 pF, T_a = 25 °C, Input: t_r = t_f = 6 ns)

Characteristics	Symbol	Note	V _{CC} (V)	Min	Тур.	Max	Unit
Output transition time	t _{TLH} ,t _{THL}		2.0	_	27	75	ns
			4.5	_	8	15	
			6.0	_	7	13	
Propagation delay time	t _{PLH} ,t _{PHL}		2.0	_	68	150	ns
(CK-Q)			4.5	_	17	30	
			6.0	_	14	26	
Propagation delay time	t _{PHL}		2.0	_	72	150	ns
(CLR-Q)			4.5	_	18	30	
			6.0	_	15	26	
Maximum clock frequency	f _{MAX}		2.0	6	15	_	MHz
			4.5	33	59	_	
			6.0	38	71	_	
Input capacitance	C _{IN}			_	5	10	pF
Power dissipation capacitance	C _{PD}	(Note 1)		_	40	_	pF

Note 1: C_{PD} is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load. Average operating current can be obtained by the equation.

 $I_{CC(opr)} = C_{PD} \times V_{CC} \times f_{IN} + I_{CC}/6 \text{ (per F/F)}$

And the total C_{PD} when n pcs of flip flop operate can be gained by the following equation.

 C_{PD} (total) = 28 + 12 × n

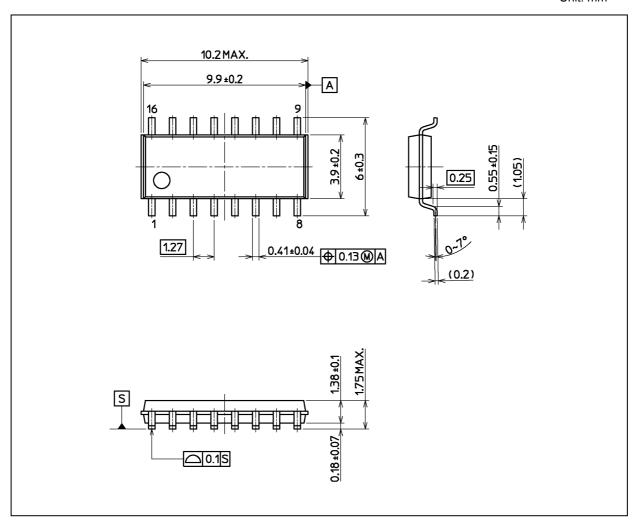
12.7. AC Characteristics (Unless otherwise specified, $C_L = 50$ pF, $T_a = -40$ to 85 °C, Input: $t_r = t_f = 6$ ns)

Characteristics	Symbol	Note	V _{CC} (V)	Min	Max	Unit
Output transition time	t _{TLH} ,t _{THL}		2.0	_	95	ns
			4.5	_	19	
			6.0	_	16	
Propagation delay time	t _{PLH} ,t _{PHL}		2.0	_	190	ns
(CK-Q)			4.5	_	38	
			6.0	_	32	
Propagation delay time	t _{PHL}		2.0	_	190	ns
(CLR-Q)			4.5	_	38	
			6.0	_	32]
Maximum clock frequency	f _{MAX}		2.0	4	_	MHz
			4.5	26	_	
			6.0	30	_	1
Input capacitance	C _{IN}			_	10	pF



Package Dimensions

Unit: mm



Weight: 0.15 g (typ.)

	Package Name(s)
Nickname: SOIC16	



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